# Course name: Growth and Characterization of Nanoelectronic Materials (EE728)

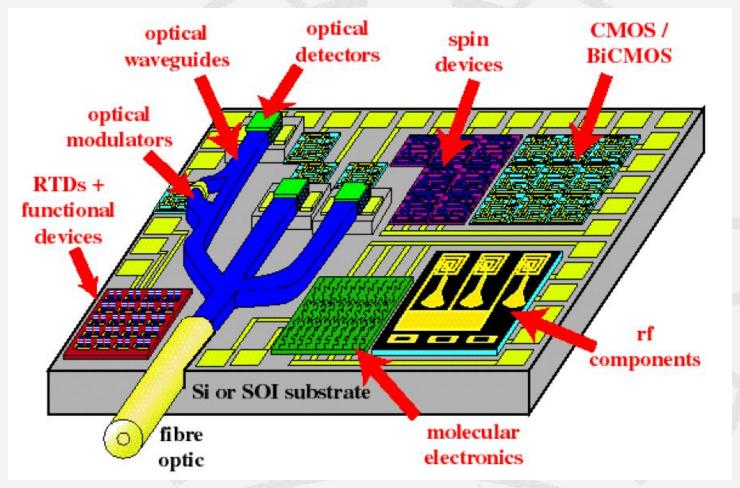
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#### **Epitaxy and modern technology!**



**The system-on-a-chip of the future?** The ability to integrate new technologies with CMOS or BiCMOS is important

Silicon integration platform

## **New challenges**

- ➤ Growth of low dimensional structures of various complexity with high degree of control and reproducibility
- ➤ It demands materials engineering at the atomic level despite lattice mismatch, chemical incompatibility, structural dissimilarity and/or differences in thermal expansion
- ➤ We have to overcome also thermodynamical limitations by using sophisticated techniques and methods

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Demands new epitaxial concepts, combination of different epitaxial growth methods and integration of other semiconductor technologies

#### **Nanotechnology**

- > Semiconductor nanostructure science and technology develops very rapidly and many present-day devices directly based on quantum mechanics.
- Future quantum devices may play important roles in information technology and multi-disciplinary nanotechnology.
- ➤ Nanotechnology is already present, e.g. the "present-day Si transistor", and will be much bigger in the future, that is at least after the "end-of-roadmap Si transistor"!

This development has strong impact on epitaxy!

# **Epitaxy**

- επι (epi) Position
- ταξιs(taxis ordered
- Orderly positioning of individual atoms
- > Order is predetermined by a crystalline substrate (host lattice)
- Requires a certain consistency in crystal structure and symmetry (matching)
- > Epitaxy is the growth of crystalline layers

# **Defining epitaxy**

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■ Substrate:
    Homoepitaxy (= layer-substrate material)
    Heteroepitaxy (another layer of material)?
  Phase equilibrium:
    Solid phase epitaxy (SPE)
    Liquid phase epitaxy (LPE)
    Vapor phase epitaxy (MBE, VPE CVD)?
■ Nature of the source material:
   Gas source MBE (GSMBE)
   Solid source MBE (SSMBE)
   Metal-organic chemical vapor deposition (MOCVD)
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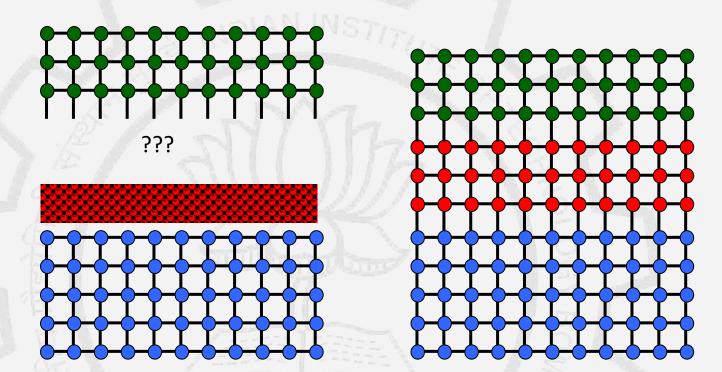
# **Epitaxy-Fundamental**

In equilibrium surface process such as condensation and re-evaporatio <u>decay and</u> <u>formation</u> of 2D cluster must obey *detailed balance*. Therefore, in equilibrium, <u>there is no net growth of a film and so crystal growth must clearly be a nonequilibrium kinetic process</u>

#### Three principle modes of growth:

- 1. Layer by layer grwoth (Frank-van der Merve, FM)
- 2. Island growth (Vollmer-Weber, VW)
- 3. Layer plus-island (Stransky-Krantanov, SK)
- 1. FM: The interaction between the substrate and layer atoms is stronger than that between neighboring layer atoms. Each layer starts to grow only when the last one has been complete.
- 2. VW: The interaction between the neighboring film atoms exceeds the overlayer substrate interaction. In this case an island deposit always means a multilayer multilayer conglomerate of adsorbed atoms.
- 3. SK: Layer followed by island formation. Many factors account for this mixed growth mode.

# **Heterostructures: Epitaxy**



**Epitaxial growth: well defined interface:** 

**→** interface engineering possible

Form a virtual crystalline substrate 
heterostructures

# **Milestone on Semiconductor Epitaxy**

1957	First Epitaxy (CVD) of Ge and Si	N.N. Sheftal	Joffe, UdSSR
1960	Ge/GaAs Heteroepitaxy	J.C. Marinace	IBM, USA
1960	Si-Epi with controlled thickness and doping	H.C. Theuerer	Bell Labs, USA
1963	Heterojunction Laser	H. Kroemer Zh.I. Alferov, R.F. Kazarinov	RCA, USA Joffe, UdSSR
1967	First Heterojunction Laser	Zh.I. Alferov	Joffe, UdSSR
1969	MOCVD of GaAs	H.M. Manasevit, W.I. Simpson	USA
1969	Surface lattice theory	L. Esaki und R. Tsu	IBM, USA
1970	GaAs/GaAsP	A.E. Blakeslee, C.F. Aiotta	IBM, USA
1971	Molecular Beam Epitaxy	A.Y. Cho	Bell Labs, USA
1972	GaAs/AlGaAs	R. Tsu, L. Esaki	IBM, USA
1974	Resonant Tunnel diode	L.L. Chang, L. Esaki, R. Tsu	IBM, USA
1980	HEMT	T. Mimura	Fujitsu, Japan
1982	Fractional Hall Effect	D.C. Tsui, H.L. Störmer, A.C. Gossard	Lawr. Liverm. Nat. Lab., USA

# **Homo- und Heteroepitaxy**

Heteroepitaxy Homoepitaxy Epi-Layer Substrate **Different Material** Similar Material as Overgrown layer is Substrate and different from overgrown layer Substrate

# **Epitaxy: Necessary conditions**

- ➤ Matching of Symmetry
- Matching of lattice parameters
- Surface free energy difference ???

#### Layer by layer growth (Mode) 2-Dimensional growth

#### perfect wetting:

$$\gamma_s > \gamma_f + \gamma_{IF}$$
  $\gamma = Surface energy$   
 $s = Substrate$   
 $f = Film, IF = interface$ 

→ Flat layer

→ called Frank-van-der Merwe (FM) or 2D-Grwoth mode







#### Layer growth (Mode) 3-Dimensional growth

#### No wetting:

$$\gamma_s < \gamma_f + \gamma_{IF}$$
  $\gamma =$ Surface energy  $s =$ Substrate  $f =$ Film, IF= interface

- → Island formation
- → called Volmer-Weber (VW) or 3D-Grwoth mode

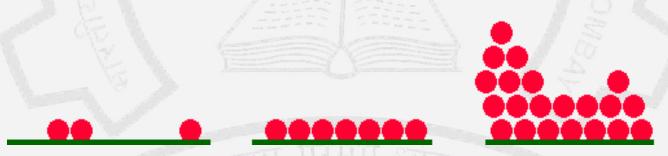


#### Layer growth (Mode) 2 - 3-Dimensional growth

#### Mixed growth:

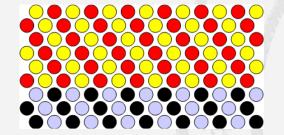
$$\gamma_s \sim \gamma_f + \gamma_{IF}$$
  $\gamma$  = Surface energy  
s = Substrate  
f = Film, IF= interface

- → Flat starting layer
- > Followed by Island formation
- → called Stranski-Krastanov (SK)-growth mode

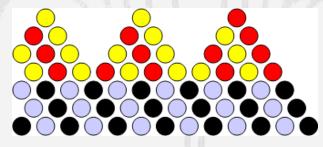


#### Different growth modes

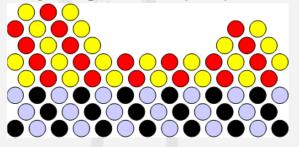
Van der Merwe layer growth (VM)



Volmer-Weber layer growth(VW)



Stranski-Krastanow layer growth(SK)



Flat layer 2D - Layer 3D –Island formation,

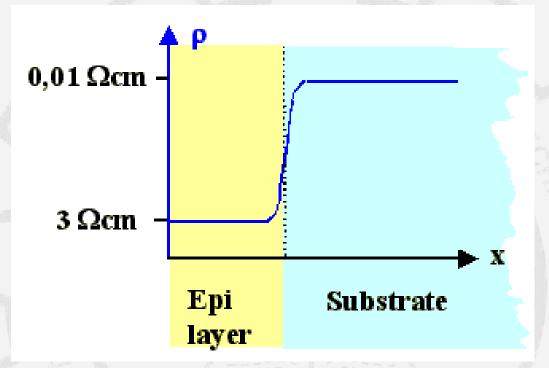
Quantum dots

2D-3D Layer; Island on 2D layer

# **Example: CVD of Si - Epitaxy**

- ➤ When SiH<sub>4</sub> gas is used in a CVD reactor, a Si layer is deposited on the wafer surface. The size of the crystallites depends on the deposition temperature.
- At high enough temperature, the ad-atoms have enough kinetic energy to move on the surface and align themselves with the underlying Si.
- ➤ This is an epitaxial layer, and the process is called Epitaxy instead of CVD---Homoepitaxy
- ➤ At lower deposition temperatures, the layer is poly-crystalline Si (consisting of small crystallites)

# Si epitaxy – controlling doping profiles



**Epitaxy is definitely needed** if a *doping profile* is required where the *resistivity in regions near the surface is larger than in the bulk.* By diffusion, you can always lower the resistivity and even change the doping type, but *increasing the resistivity by diffusion* is not realistically possible.

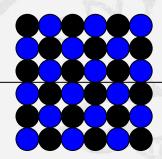
## **Homo- und Heteroepitaxy**

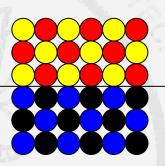
Homoepitaxy

Heteroepitaxy

Epi-Layer

Substrate



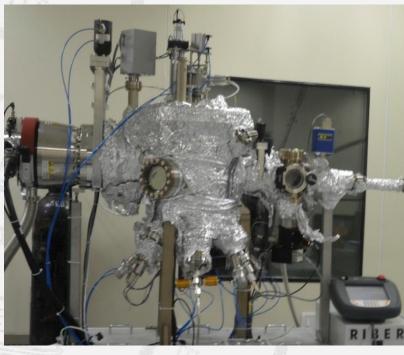


Same materials as substrate

Different Material from Substrat

#### **Molecular Beam Epitaxy laboratory at IIT Bombay**





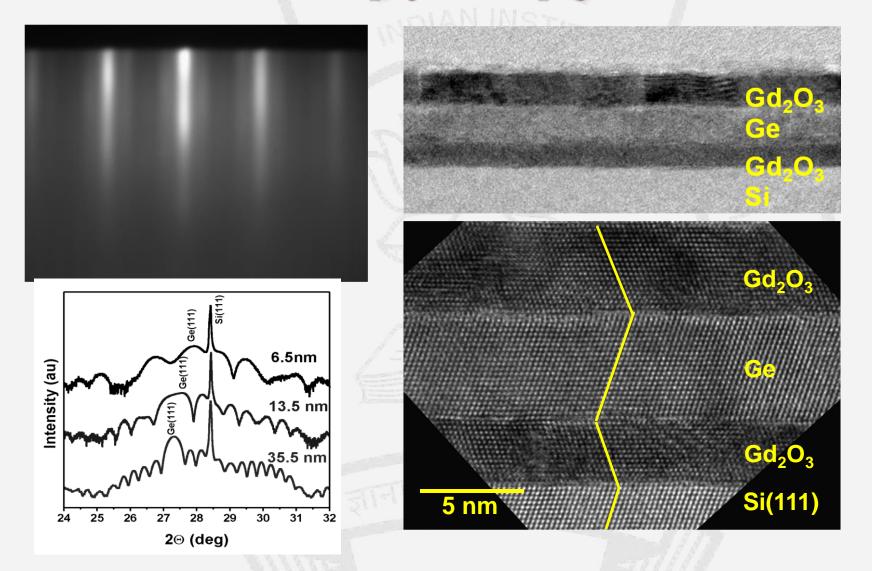
3" Molecular Beam Epitaxy System for III-Nitride

III-V semiconductors GaN,  $AI_xGa_{(1-x)}N$ , AIN,  $In_xGa_{(1-x)}N$ , InN and InAIN

1" Molecular Beam Epitaxy System for group IV and oxide

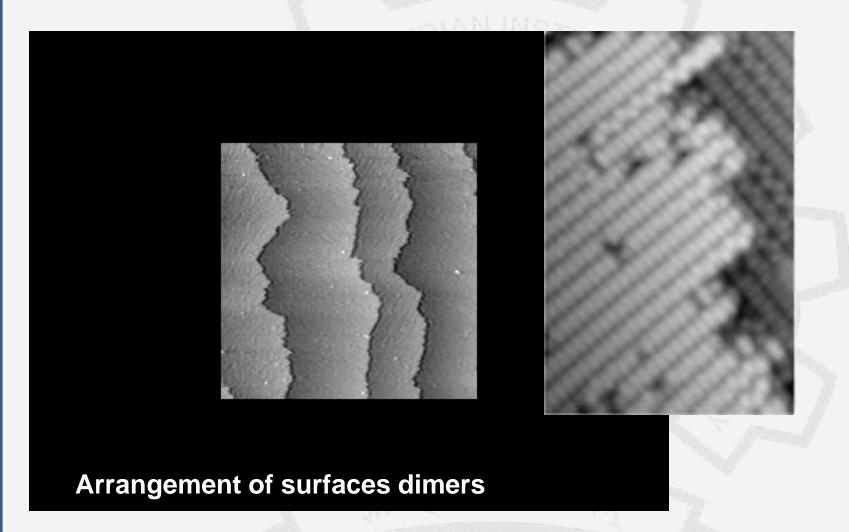
**Group IV semiconductors Si, Ge, Sn and oxides** 

# Example: Epitaxial Gd<sub>2</sub>O<sub>3</sub>/Ge/Gd<sub>2</sub>O<sub>3</sub>-Si Heterostructure



A. Laha, MBE @ IITB A. Laha, Nanotechnology 20, (2009) 475604

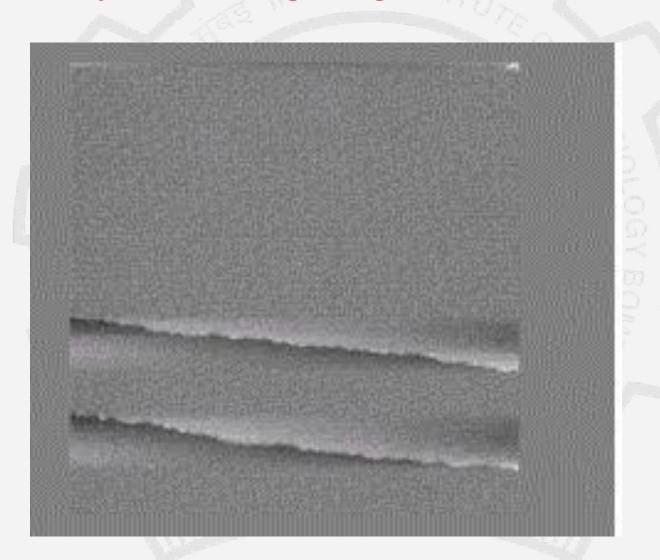
# **Step/Terraces on Si(001)**



# Homoepitaxy of Si on Si(111)

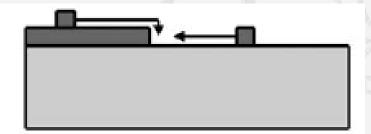


# Transition from the Frank-van der Merwe growth to the step flow during the growth of Cu on W (111)



# Van der Merwe layer growth

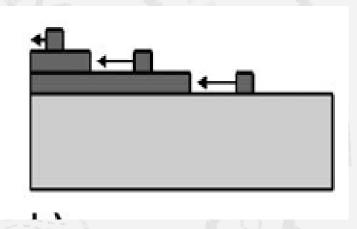
2D - Layer growth



**Nucleation** 

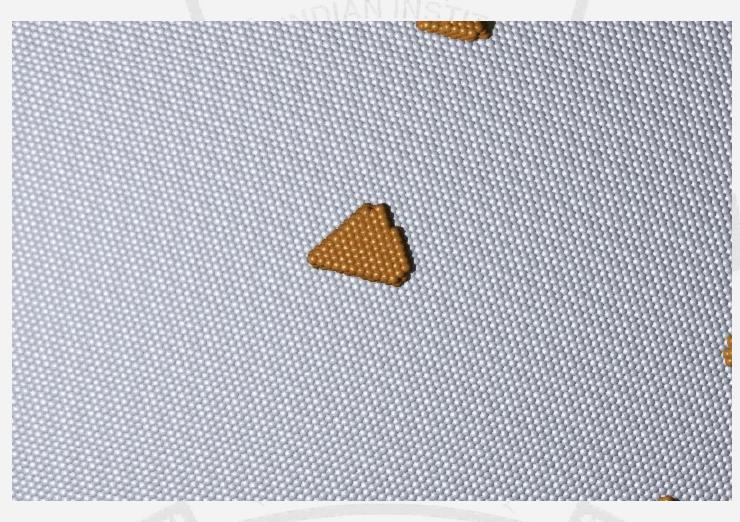
Transport from higher to lower levels

(Step-Flow)



Simultaneous growth

# Heteroepitaxy



#### References

#### CVD:

- Hugh O. Pierson, Handbook of chemical vapor deposition (CVD): principles, technology and applications, Noyes Pub., 1992.
- Langmuir,"The vapor pressure of metallic Tungsten", Physical Review,
   November 1913.
- S. Sivaram, "Chemical Vapor Deposition: thermal and plasma deposition of electronic materials", Van Nostrand Reinhold, 1995.
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